Lecture 7 - 07-04-2020

Bounding statistical risk of a predictor
Design a learning algorithm that predict with small statistical risk

$$(D, \ell) \qquad \ell_d(h) = \mathbb{E}\left[\, \ell(y), h(x) \,\right]$$

were D is unknown

$$\ell(y, \hat{y}) \in [0, 1] \quad \forall y, \hat{y} \in Y$$

We cannot compute statistical risk of all predictor.
We assume statistical loss is bounded so between 0 and 1. Not true for all losses (like logarithmic).
Before design a learning algorithm with lowest risk, How can we estimate risk?
We can use test error → way to measure performances of a predictor h. We want to link test error and risk.
Test set $S' = \{(x'_1, y'_1)...(x'_n, y'_n)\}$ is a random sample from D
How can we use this assumption?
Go back to the definition of test error

Sample mean (IT: Media campionaria)

$$\hat{\ell}_s(h) = \frac{1}{n} \cdot \sum_{t=1}^{n} \ell(\hat{y}_t, h(x'_t))$$

i can look at this as a random variable $\ell(y'_t, h(x'_t))$

$$\mathbb{E}\left[\, \ell(y'_t, h(x'_t)) \right] = \ell_D(h) \longrightarrow \textit{risk}$$

Using law of large number (LLN), i know that:

$$\hat{\ell} \longrightarrow \ell_D(h) \qquad as \quad n \to \infty$$

We cannot have a sample of $n = \infty$ so we will introduce another assumption: the Chernoff-Hoffding bound

1.1 Chernoff-Hoffding bound

$$Z_1, ..., Z_n \quad \textit{iid random variable} \qquad \mathbb{E}\left[Z_t\right] = u$$

all drawn for the same distribution

$$t = 1, ..., n \qquad and \qquad 0 \leq Z_t \leq 1 \qquad t = 1, ..., n \quad then \quad \forall \varepsilon > 0$$

$$\mathbb{P}\left(\frac{1}{n}\cdot\sum_{t=1}^{n} z_t > u+\varepsilon\right) \leq e^{-2\,\varepsilon^2\,n} \qquad or \qquad \mathbb{P}\left(\frac{1}{n}\cdot\sum_{t=1}^{n} z_t < u+\varepsilon\right) \leq e^{-2\,\varepsilon^2\,n}$$

as sample size then $\downarrow$

$$Z_t = \ell(Y_t', h(X_t')) \in [0,1]$$

$(X_1', Y_1')...(X_n', Y_N')$ are *iid* therefore,
$\ell\left(Y_t', h\left(X_t'\right)\right) \quad t = 1, ..., n \quad$ are also *iid*
We are using the bound of e to bound the deviation of this.

1.2 Union Bound

Union bound: a collection of event not necessary disjoint, then i know that probability of the union of this event is the at most the sum of the probabilities of individual events

$$A_1, ..., A_n \qquad \mathbb{P}\left(A_1 \cup ... \cup A_n\right) \leq \sum_{t=1}^{n} \mathbb{P}\left(A_t\right)$$

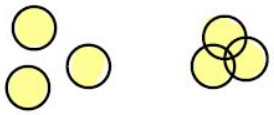

Figure 1.1: Example

that's why $\leq$

$$\mathbb{P}\left(\mid \hat{\ell}_{s'}\left(h\right) - \ell_D\left(h\right) \mid > \varepsilon\right)$$

This is the probability according to the random draw of the test set.

If test error differ from the risk by a number epsilon > 0. I want to bound the probability. This two thing will differ by more than epsilon. How can i use the Chernoff bound?

$$\mid \hat{\ell}_{s'}\left(h\right) - \ell_D\left(h\right) \mid > \varepsilon \quad \Rightarrow \quad \hat{\ell}_{s'}\left(h\right) - \ell_D\left(h\right) > \varepsilon \quad \vee \quad \hat{\ell}_D\left(h\right) - \ell_{s'}\left(h\right) > \varepsilon$$

Figure 1.2: Example

$$A, B \qquad A \Rightarrow B \qquad \mathbb{P}(A) < \mathbb{P}(B)$$

$$\mathbb{P}\left(\mid \hat{\ell}_{s'}(h) - \ell_D(h) \mid > \varepsilon\right) \leq \mathbb{P}\left(\left|\hat{\ell}_{s'}(h) - \ell_D(h)\right|\right) \quad \cup \quad \mathbb{P}\left(\left|\hat{\ell}_D(h) - \ell_{s'}(h)\right|\right) \leq$$

$$\leq \mathbb{P}\left(\hat{\ell}_{s'} > \ell_D(h) + \varepsilon\right) + \mathbb{P}\left(\hat{\ell}_{s'} < \ell_D(h) - \varepsilon\right) \quad \leq \quad 2 \cdot e^{-2\varepsilon^2 n} \quad \Rightarrow \textit{we call it } \delta$$

$$\varepsilon = \sqrt{\frac{1}{2 \cdot n} \ln \frac{2}{\delta}}$$

The two events are disjoint

This mean that probability of this deviation is at least delta!

$$\mid \hat{\ell}_{s'}(h) - \ell_D(h) \mid \leq \sqrt{\frac{1}{2 \cdot n} \ln \frac{2}{\delta}} \qquad \textit{with probability at least } 1 - \delta$$

Test error of true estimate is going to be good for this value (δ)
Confidence interval for risk at confidence level 1-delta.

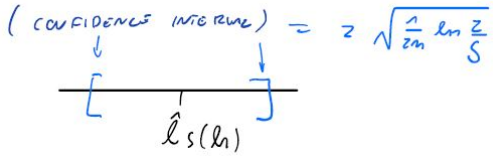

Figure 1.3: Example

I want to take $\delta = 0,05$ so that $1 - \delta$ is 95%. So test error is going to be an estimate of the true risk which is precise that depend on how big is the test set (n).
As n grows I can pin down the position of the true risk.
This is how we can use probability to make sense of what we do in practise.
If we take a predictor h we can compute the risk error estimate.

We can measure how accurate is our risk error estimate.
Test error is an estimate of risk for a given predictor (h).

$$\mathbb{E}\left[\ell\left(Y_t', h\left(X_t'\right)\right)\right] = \ell_D\left(h\right)$$

h is fixed with respect to S' $\longrightarrow$ h does not depend on the test set. So learning algorithm which produce h not have access to test set.
If we use test set we break down this equation.

Now, how to **build a good algorithm?**
Training set $S = \{(x_1, y_1) \ldots (x_m, y_m)\}$ random sample
A $A\left(S\right) = h$ predictor output by A given S where A is learning algorithm as function of traning set S.
$\forall\, S$ $A\left(S\right) \in H$ $h^* \in H$

$\ell_D\left(h^*\right) = min\, \ell_D\left(h\right)$ $\hat{\ell}_s\left(h^*\right)$ *is closed to* $\ell_D\left(h^*\right)$ $\longrightarrow$ **it is going to have small error**
where $\ell_D\left(h^*\right)$ is the training error of h^*

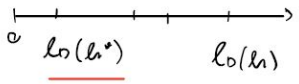

Figure 1.4: Example

This guy $\ell_D\left(h^*\right)$ is closest to 0 since optimum

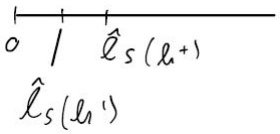

Figure 1.5: Example

In risk we get opt in h^* but in empirical one we could get another h' better than h^+

In order to fix on a concrete algorithm we are going to take the empirical Islam minimiser (ERM) algorithm.
A is ERM on H $(A) = \hat{h} = (\in)\, argmin\, \hat{\ell}_S\left(h\right)$
Once I piack $\hat{h}$ i can look at training error of ERM

$$\hat{\ell}_S\left(\hat{h}\right) of \hat{h} = A(S)$$

where $\hat{\ell}_S$ is the training error

Should $\hat{\ell}_S\left(\hat{h}\right)$ be close to $\ell_D\left(\hat{h}\right)$?
I'm interested in empirical error minimiser and do a trivial decomposition.

$$\begin{aligned}
\ell_d\left(\hat{h}\right) = \quad & \ell_D\left(\hat{h}\right) - \ell_d\left(h^*\right) + && \longrightarrow \textbf{Variance error} \Rightarrow \textbf{Overfitting} \\
& + \ell_d\left(h^+\right) - \ell_d\left(f^*\right) + && \longrightarrow \textbf{Bias error} \Rightarrow \textbf{Underfitting} \\
& + \ell_D\left(f^*\right) && \longrightarrow \textbf{Bayes risk} \Rightarrow \textbf{Unavoidable}
\end{aligned}$$

Even the best predictor is going to suffer that

$$f^* \textit{ is } \textbf{\textit{Bayes Optimal}} \textit{ for } (D, \ell)$$
$$\forall h \qquad \ell_D\left(h\right) \geq \ell_D\left(f^*\right)$$

If $f^* \notin H$ then $\ell_D\left(h^*\right) > \ell_D(f^*)$

If i pick h^* I will pick some error because we are not close enough to the risk.
We called this component **bias error**.
Bias error is responsible for underfitting (when training and test are close to each but they are both high :( )
Variance error over fitting

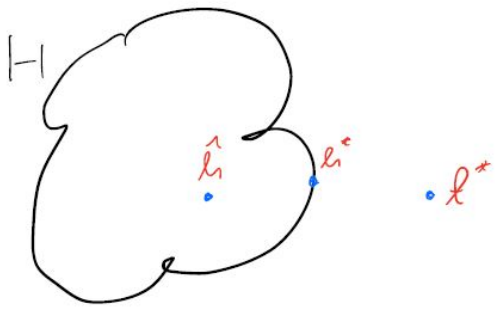

Figure 1.6: Draw of how $\hat{h}$, h^* and f^* are represented

Variance is a random quantity and we want to study this. We can always get risk from training error.

1.3 Studying overfitting of a ERM

We can bound it with probability.
I add and subtract trivial traning error $\hat{\ell}_S(h)$

$$\begin{aligned}\ell_D\left(\hat{h}\right) - \ell_d(h^*) &= \ell_D\left(\hat{h}\right) - \hat{\ell}_S(h) + \hat{\ell}_S\left(\hat{h}\right) - \ell_D(h^*) \leq \\ &\leq \ell_D\left(\hat{h}\right) - \hat{\ell}_S\left(\hat{h}\right) + \hat{\ell}_S(h^*) - \ell_D(h^*) \leq \\ &\leq |\,\ell_D\left(\hat{h}\right) - \hat{\ell}_S(h)\,| + |\,\hat{\ell}_S\left(h^+\right) - \ell_D(h^*)\,| \leq \\ &\leq 2 \cdot max\,|\hat{\ell}_S(h) - \ell_D(h)\,|\end{aligned}$$

(no probability here)
Any given $\hat{h}$ **minising** $\hat{\ell}_S(h)$

Now assume we have a large deviation

$$Assume \quad \ell_D\left(\hat{h}\right) - \ell_D(h^*) > \varepsilon \qquad \Rightarrow \qquad max\,|\,\hat{\ell}_S(h) - \ell_D(h)\,| > \frac{\varepsilon}{2}$$

We know $\ell_d\left(\hat{h}\right) - \ell_D(h^*) \leq 2 \cdot max\,|\,\hat{\ell}_S(h) - \ell_D(h)\,| \Rightarrow$

$$\Rightarrow \quad \exists h \in H \qquad |\,\hat{\ell}_S(h) - \ell_D(h)\,| > \frac{3}{2} \qquad \Rightarrow$$

with $|H| < \infty$

$$\Rightarrow U\left(|\,\hat{\ell}_S(h) - \ell_D(h)\,|\right) > \frac{3}{2}$$

$$\mathbb{P}\left(\ell_D\left(\hat{h}\right) - \ell_D(h^*) > \varepsilon\right) \leq \mathbb{P}\left(U\left(|\,\hat{\ell}_S(h) - \ell_D(h)\,|\right) > \frac{3}{2}\right) \leq$$

$$\leq \sum_{h \in H} \mathbb{P}\left(|\,\hat{\ell}_S(h) - \ell_D(h)\,| > \frac{3}{2}\right) \leq \sum_{h \in H} 2 \cdot e^{-2\left(\frac{\varepsilon}{2}\right)^2 m} \leq$$

Union Bound Chernoff. Hoffding bound ($\mathbb{P}(...)$)

$$\leq 2 \cdot |H| e^{-\frac{\varepsilon^2}{2} m}$$

Solve for $\varepsilon \qquad 2 \cdot |H| e^{-\frac{\varepsilon^2}{2} m} = \delta$

$$Solve\ for\ \varepsilon \longrightarrow \quad \varepsilon = \sqrt{\frac{2}{m} \cdot \ln \cdot \frac{2|H|}{\delta}}$$

$$\ell_D\left(\hat{h}\right) - \ell_D\left(h^*\right) \quad \leq \quad \sqrt{\frac{2}{m} \cdot \ln \cdot \frac{2|H|}{\delta}}$$

With probability at least $1 - \delta$ with respect to random draw of S.
We want $m >> ln|H|$ $\longrightarrow$ in order to avoid overfitting